

Vishay Siliconix

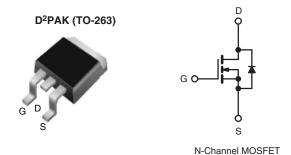
RoHS'

COMPLIANT

HALOGEN FREE

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	400				
R _{DS(on)} (Ω)	V _{GS} = 10 V 0.55				
Q _g (Max.) (nC)	63				
Q _{gs} (nC)	9.0				
Q _{gd} (nC)	32				
Configuration	Single				



FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The D²PAK (TO-263) is a surface mount power package capable of accommodating die size up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The D²PAK (TO-263) is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

ORDERING INFORMATION						
Package	D ² PAK (TO-263)	D ² PAK (TO-263)	D ² PAK (TO-263)			
Lead (Pb)-free and Halogen-free	SiHF740S-GE3	SiHF740STRL-GE3 ^a	SiHF740STRR-GE3 ^a			
Lead (Pb)-free	IRF740SPbF	IRF740STRLPbFa	IRF740STRRPbFa			
Lead (Pb)-iree	SiHF740S-E3	SiHF740STL-E3 ^a	SiHF740STR-E3 ^a			

Note

a. See device orientation.

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	less otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	400	V	
Gate-Source Voltage			V_{GS}	± 20	7 v	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I-	10		
Continuous Drain Current	VGS at 10 V	T _C = 100 °C	I _D	6.3	Α	
Pulsed Drain Current ^a			I _{DM}	40		
Linear Derating Factor				1.0	W/°C	
Linear Derating Factor (PCB Mount)e				0.025	VV/ C	
Single Pulse Avalanche Energy ^b			E _{AS}	520	mJ	
Avalanche Current ^a			I _{AR}	10	А	
Repetitive Avalanche Energy ^a			E _{AR}	13	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$				125	W	
Maximum Power Dissipation (PCB Mount) ^e			P_{D}	3.1		
Peak Diode Recovery dV/dt ^c			dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d	7 °C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 50 \text{ V}$, starting $T_{LI} = 25 \,^{\circ}\text{C}$, $L = 9.1 \, \text{mH}$, $R_{cI} = 25 \,^{\circ}\Omega$, $I_{AS} = 10 \,^{\circ}\Lambda$ (see fig. 12).
- c. $I_{SD} \le 10A$, $dI/dt \le 120$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.
- e. When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF740S, SiHF740S

Vishay Siliconix



THERMAL RESISTANCE RATINGS						
PARAMETER SYMBOL TYP. MAX. UNIT						
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 250 μA	400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.49	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	· V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zara Cata Valtaga Drain Current		V _{DS} =	= 400 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 320 V	', V _{GS} = 0 V, T _J = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 6.0 A ^b	-	-	0.55	Ω
Forward Transconductance	9fs	V _{DS} =	50 V, I _D = 6.0 A ^b	5.8	-	-	S
Dynamic							
Input Capacitance	C _{iss}		$V_{GS} = 0 V$	-	1400	-	pF
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$	-	330	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.	0 MHz, see fig. 5	-	120	-	
Total Gate Charge	Qg	V _{GS} = 10 V		-	-	63	nC
Gate-Source Charge	Q _{gs}			-	-	9.0	
Gate-Drain Charge	Q_{gd}			-	-	32	
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r	$V_{DD} = 200 \text{ V, } I_D = 10 \text{ A,}$ $R_g = 9.1 \Omega, R_D = 20 \Omega, \text{ see fig. } 10^b$		-	27	-	ns
Turn-Off Delay Time	t _{d(off)}			-	50	-	
Fall Time	t _f			-	24	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from		_	4.5	-	nH
Internal Source Inductance	L _S	package and center of die contact		-	7.5	-	111
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	10	А
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	40	^
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}C$	V_{c} , $I_{S} = 10 \text{ A}$, $V_{GS} = 0 \text{ V}^{b}$		-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C L	- 10 A dl/dt - 100 A/usb	_	370	790	ns
Body Diode Reverse Recovery Charge	Q_{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 10 \text{A}, dI/dt = 100 \text{A/} \mu \text{s}^{\text{b}}$		-	3.8	8.2	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	n-on is dominated by L _S and L _D			L _D)	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

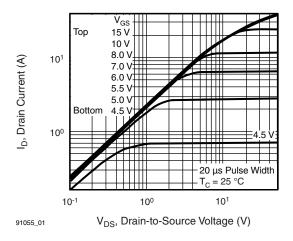


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

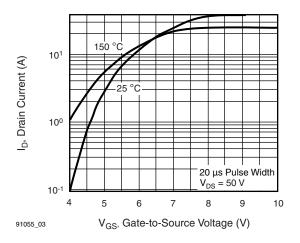


Fig. 3 - Typical Transfer Characteristics

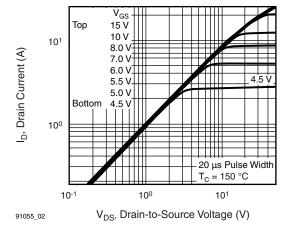


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

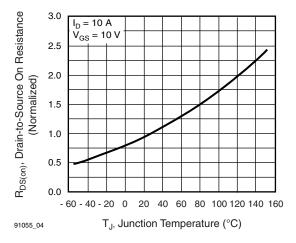


Fig. 4 - Normalized On-Resistance vs. Temperature

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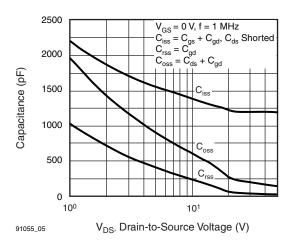


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

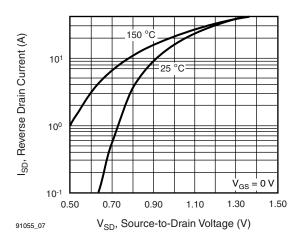


Fig. 7 - Typical Source-Drain Diode Forward Voltage

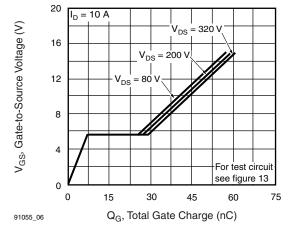


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

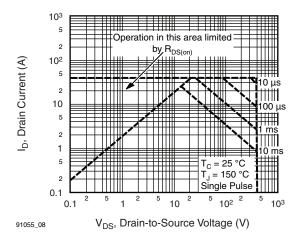


Fig. 8 - Maximum Safe Operating Area





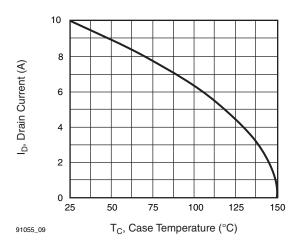


Fig. 9 - Maximum Drain Current vs. Case Temperature

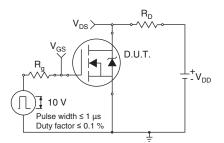


Fig. 10a - Switching Time Test Circuit



Fig. 10b - Switching Time Waveforms

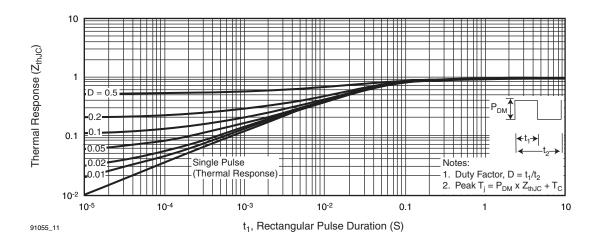
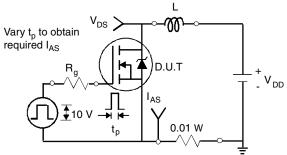
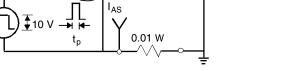


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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 V_{DS} $\rm V_{\rm DD}$

Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

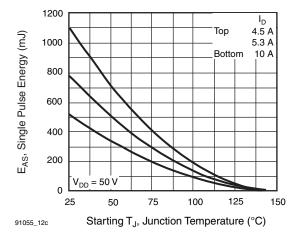


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

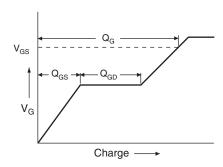


Fig. 13a - Basic Gate Charge Waveform

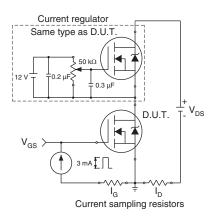
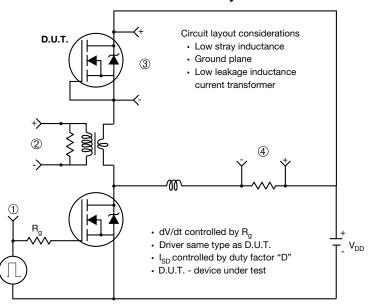


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



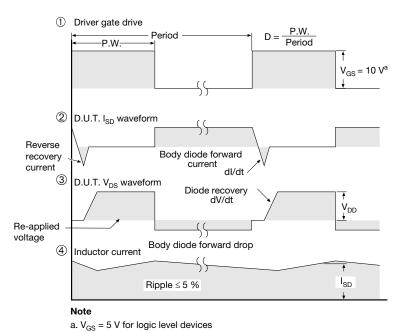


Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?91055.





TO-263AB (HIGH VOLTAGE)







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	-E1-	₩	<u> </u>	7

	MILLIN	METERS	INC	HES
DIM.	MIN. MAX.		MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIN	METERS	INC	HES		
DIM.	MIN.	MIN. MAX.		MAX.		
D1	6.86	-	0.270	-		
E	9.65	10.67	0.380	0.420		
E1	6.22	-	0.245	i		
е	2.54	BSC	0.100 BSC			
Н	14.61	15.88	0.575	0.625		
L	1.78	2.79	0.070	0.110		
L1	-	1.65	ı	0.066		
L2	-	1.78	i	0.070		
L3	0.25 BSC		0.010	BSC		
L4	4.78	5.28	0.188	0.208		

DWG: 5970 Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).

ECN: S-82110-Rev. A, 15-Sep-08

- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

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Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

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